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|-----------------------------------|---------------------------------------|--|--|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/540,663 |  | Applicant(s)/Patent Under<br>Reexamination<br>YEWDALL ET AL. |             |
|                                   | Examiner<br>CLOUD K. LEE              |  | Art Unit<br>3753   | Page 1 of 2 |

#### U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name                         | Classification |
|---|---|--|-----------------|------------------------------|----------------|
| * | A | US-2,704,085 A                                   | 03-1955         | WADSWORTH RAYMOND H; et. al. | 137/81.1       |
| * | B | US-2,777,463 A                                   | 01-1957         | CHARLES BOSWELL ARTHUR       | 137/341        |
| * | C | US-3,560,706 A                                   | 02-1971         | Fonseca, Eduardo J. A.       | 392/485        |
| * | D | US-3,580,267 A                                   | 05-1971         | Baker, Ralph J.              | 137/203        |
| * | E | US-3,706,872 A                                   | 12-1972         | Trabilcy, William J.         | 392/469        |
| * | F | US-5,224,510 A                                   | 07-1993         | Pericles, Nico               | 137/487.5      |
| * | G | US-5,531,245 A                                   | 07-1996         | Sparks, Anthony L.           | 137/341        |
| * | H | US-5,837,970 A                                   | 11-1998         | Jilek, Gerard T.             | 219/201        |
| * | I | US-5,865,421 A                                   | 02-1999         | Ono, Hirofumi                | 251/129.02     |
| * | J | US-5,941,271 A                                   | 08-1999         | Chovan, Dale                 | 137/204        |
| * | K | US-6,227,236 B1                                  | 05-2001         | Kusumoto et al.              | 137/341        |
| * | L | US-6,311,710 B1                                  | 11-2001         | Facas et al.                 | 137/1          |
| * | M | US-2003/0178064 A1                               | 09-2003         | Fukuda et al.                | 137/341        |

#### FOREIGN PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

#### NON-PATENT DOCUMENTS

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

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|                                   |                                       |  |  |             |
|-----------------------------------|---------------------------------------|--|--|-------------|
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|                                   | Examiner<br>CLOUD K. LEE              |  | Art Unit<br>3753   | Page 2 of 2 |

#### U.S. PATENT DOCUMENTS

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name             | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,805,152 B2                                  | 10-2004         | Kanzaka et al.   | 137/341        |
| * | B | US-6,994,319                                     | 02-2006         | Yudovsky, Joseph | 251/331        |
| * | C | US-2001/0028049                                  | 10-2001         | Mamyo, Mitsuru   | 251/331        |
|   | D | US-  |                 |                  |                |
|   | E | US-  |                 |                  |                |
|   | F | US-  |                 |                  |                |
|   | G | US-  |                 |                  |                |
|   | H | US-  |                 |                  |                |
|   | I | US-  |                 |                  |                |
|   | J | US-  |                 |                  |                |
|   | K | US-  |                 |                  |                |
|   | L | US-  |                 |                  |                |
|   | M | US-  |                 |                  |                |

#### FOREIGN PATENT DOCUMENTS

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|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
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|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
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